

Search Notes

Application No.

10/071,370

Examiner

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Applicant(s)

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Art Unit

1647

SEARCHED

Class	Subclass	Date	Examiner
424	198.1	9/21/2004	JML
435	69.1	9/21/2004	JML
	252.3	9/21/2004	JML
	320.1	9/21/2004	JML
530	350	9/21/2004	JML
	399	9/21/2004	JML
536	23.5	9/21/2004	JML
	24.31	9/21/2004	JML
Updated		2/11/05	JML

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
424	198.1	2/11/05	JML
435	69.1, 252.3		
	320.1		
530	350, 399		
536	23.5, 24.31	2/11/05	JML
Stic Sequence search of Seq ID: 3, 4		2/4/05	JML

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Stic Search of Commercial and Patent Databases: See Attached Search Report	9/17/2004	JML
East Search: Text and Inventors Name Search: See attached Search Report.	9/21/2004	JML
PALM: Inventor's Name Search.	9/21/2004	JML
Updated	2/11/05	JML